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## Mechanisms of residual polymer removal in solvent mixtures after the graphene transfer and effects on channel conductivity gate control

N.P. Nekrasov<sup>⊠</sup>, A.V. Romashkin, L.A. Barsukov, K.G. Nikitin, D.D. Levin, I.I. Bobrinetskiy, V.K. Nevolin

National Research University of Electronic Technology, Moscow, Russia

☑ 8141147@gmail.com

**Abstract.** After graphene transfer, solvent mixtures were used to remove residual PMMA, which efficiency was estimated by AFM, Raman spectroscopy, and CVC. That post-treatment gives: stress relaxation (2D peak shift, compared to trichloroethylene), 2D/G intensity ratio 1.1 changes to 2.6, clean graphene regions exceed 100–150 nm size; threshold point shifts to zero but the conductivity and mobility reduce. Ethanolamine functionalizes both PMMA and graphene.

Keywords: graphene transfer, polymer removal, sensor, polymethyl methacrylate

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## Механизмы удаления остаточного полимера в смесях растворителей после переноса графена и влияние на проводимость и управление канала

Н.П. Некрасов<sup>⊠</sup>, А.В. Ромашкин, Л.А. Барсуков, К.Г. Никитин, Д.Д. Левин, И.И. Бобринецкий, В.К. Неволин

Национальный исследовательский университет «МИЭТ», Москва, Россия

### ≅ 8141147@gmail.com

Аннотация. Остаточный ПММА удалялся в смеси растворителей, эффективность оценивали по ACM, спектроскопии КР и ВАХ. При обработке: напряжения релаксируют (смещение 2D пика); 2D/G меняется: с ~1,1 до 2,6; чистые области становятся 100-150 нм; пороговая точка смещается к нулю, но проводимость и подвижность снижаются. Этаноламин функционализирует и ПММА и графен.

Ключевые слова: перенос графена, сенсор, удаление полимера, ПММА

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#### Introduction

The removal of polymer residuals, that are left after the graphene transfer used for the sensor channel, is still an important problem [1]. Residual PMMA blocks the active sensor area and decreases its efficiency, affecting the limit of detection, sensitivity, response time, and sensor parameters reproducibility [2–4]. PMMA tends to strongly interact with graphene in the near-surface layer [5], therefore needs new ways to delete it from graphene, rather than the methods based on bulk material dissolution. We suggest some new methods to remove the near-surface layer using: rinsing in solvent/non-solvent mixture; swelling or functionalization of the PMMA layer. Although the use of mixtures of solvents [6] and some special [1] for removing PMMA, provides a sufficiently high quality of CVD graphene transferred to the target substrate. Nevertheless, some mechanisms for removing PMMA molecules from the graphene and the solvent molecules' interaction with PMMA remain unclear. Despite the use of low molecular weight PMMA and other polymers, plasma modification, etc. [7] the functionalization of residual PMMA with the role of polar side groups increase for its subsequent more efficient removal has not been found in the literature. Thus, the study of the mechanisms of residual PMMA removal from graphene using different solvent mixtures and the PMMA functionalization, as well as graphene characteristics changes as the results of that cleaning, were the goals of this work. The rinsing efficiency and PMMA layer parameters change were estimated by AFM, Raman spectroscopy, and CVC measurements of the graphene layer.

### Materials and methods

CVD graphene (Graphenea, Spain) on Cu foil was used. PMMA with  $M_{\nu} \sim 495$  kDa 2 % in anisole (MicroChem, USA) was used as the supporting layer required for transfer onto Si substrate with 300 nm SiO<sub>2</sub> layer with Cr/Au microelectrodes (50 µm gap with 100 µm channel width). PMMA was spin-coated onto graphene at 2.5 krpm, then annealed at 110 °C. To remove polymer residuals film on SiO<sub>2</sub>/Si substrate was rinsed in different solvents or mixtures: firstly, trichloroeth-ylene (TCE) at room temperature, and then consequently diacetone alcohol (DAA):water (H<sub>2</sub>O) (4:1), tetrahydrofuran (THF):H<sub>2</sub>O (Komponent-Reaktiv, Russia) (7:3), ethanolamine (EA) (Sigma-Aldrich):THF (3:7) for half an hour at ~60 °C to increase the dissolution rate. Residual PMMA removing efficiency was investigated using AFM (Solver-Pro, NT-MDT, Russia) and Raman spectroscopy (Centaur U HR, 532 nm laser, Nano Scan Technology, Russia). CVC measurements (IPPP5/1, MNIPI, Belarus) were carried out using a liquid gate (Ag/AgCl in 0.1x PBS 7.0 pH) with PDMS mask with well diameter 700 µm to localize liquid area, drain-source voltage was 10 mV.

### **Results and Discussion**

In comparison with trichloroethylene (TCE), for DAA:H<sub>2</sub>O there is stress relaxation or doping (2D peak shifts from 2696 to 2690 cm<sup>-1</sup>), but with no 2D/G ratio change (~1.1, Fig. 1), although the layer thickness increased (from 3.7 to 4 nm, Fig. 2, *a*, *c*). This behavior can be explained by polymer swelling in the solvent with polymer molecular chain conformations changing relative to each other and graphene. That leads to the stress relaxation formed before: during the graphene transfer with an initially continuous PMMA layer and their heat treatment on the substrate. However, such PMMA swelling is not enough to redistribute PMMA molecules and remove them from graphene. Increasing solvent temperature potentially can improve PMMA removal efficiency. But used temperature already results in the graphene being partially removed from SiO<sub>2</sub>, which appears as the curled edge of the graphene layer with residual PMMA (Fig. 2,*c*). Thus, due to the more energy-favorable PMMA-graphene interaction compared to PMMA-PMMA,

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Fig. 1. Raman spectra (a), 2D position (b), 2D/G peak ratio (c) of graphene rinsed in various solvents

instead of easy removal of PMMA in TCE, which is one of the best solvents for PMMA [8], the removal of the near-surface PMMA layer from graphene does not occur. And as the temperature increases, only the graphene removal along with the residual PMMA layer occurs, especially if a large part of graphene was covered by PMMA. Thus, a two-stage treatment was carried out: (i) the main PMMA layer thickness was gradually removed in TCE at 25 °C, (ii) the residual near-surface PMMA layer was removed in a solvents mixture not exceed 60 °C.

For THF:H<sub>2</sub>O, 2D/G increases to 1.6-1.9, which with AFM data (thickness ~2.2 nm), indicates that graphene regions without PMMA increased to ~50 nm. In our previous work [9], similar processing led to the graphene areas formation on Cu foil, on the contrary, with residual PMMA on that areas with slightly smaller sizes, with fluorescence from such quantum dots. In current work also small graphene regions, but without PMMA, don't provide fluorescence on SiO<sub>2</sub>, but also suppress 2D/G. Due to its small specific area contribution, they can't change 2D/G ratio in the case of TCE compared to full PMMA-covered graphene. If its contribution and at the same time its size would be larger, 2D/G should be ~5 [9]. Graphene regions contribution, locally with high quality (2D/G ~5 [1, 9]), could be suppressed by the larger proportion of areas with PMMA (2D/G ~1) that total contribution is more than 2/3 of the whole area (Fig. 2,d).



Fig. 2. AFM of graphene cleaned by: TCE (a), AFM (b), DAA:H<sub>2</sub>O (c), THF:H<sub>2</sub>O (d, e),
(e) correspond to another sample, EA:THF (f). Scale bars are 1 μm

At the same time, with a small size of such small islands of graphene with PMMA or, similarly, without PMMA limited by PMMA, due to the possibility of fluorescence in them on copper foil [9], the energy levels position can also significantly change for them, even in the case of graphene on  $SiO_2$ , accompanied by significant suppression of the 2D intensity for such regions. Thus, even in the presence of a large proportion of graphene without PMMA, the 2D/G ratio will be significantly suppressed when the regions with and without PMMA are small in size. Observed changes in the shape and area of the graphene regions without PMMA when using THF, points to the redistribution and only partial PMMA removal, especially on  $SiO_2$  at an increased annealing temperature after transfer.

2D/G of AFM-cleaned graphene was higher: ~2.7. The thickness of the graphene layer is still larger (0.7–1 nm) than that observed for exfoliated graphene, transferred without polymers and solvents. The increased thickness is associated with the residual water molecules on SiO<sub>2</sub> under graphene for PMMA-transferred CVD graphene [10]. A further 2D/G ratio increase in comparison with the AFM-cleaned graphene is possible using a different substrate containing fewer residual water molecules and functional groups (such as Si-OH) on the surface or with special cleaning of the substrates [1]. Similar is realized for exfoliated graphene, which interacts weakly with an underlying graphene sublayer separating the upper layer from SiO<sub>2</sub>, in comparison with the graphene directly on SiO<sub>2</sub> [11]. The decrease in 2D/G is due to the formation of graphene regions with different types and charge densities [12]. It leads to a broadening and, accordingly, a 2D peak intensity decrease. That is a result of the graphene interaction with a similar substrate in our case also containing regions with different potential.

For EA:THF, the 2D peak is shifted from 2690 to 2681 cm<sup>-1</sup> and 2D/G increases to 2.6 which points to extended graphene regions without PMMA. Therefore, EA functionalization of PMMA helps to remove PMMA, but graphene is functionalized too (D/G~0.7). Although the AFM thickness is ~5 nm. The ethanolamine functionalization of PMMA [13] makes it capable of retaining a sufficient number of solvent and H<sub>2</sub>O molecules [14]. That forms the effective layer thickness increase. Additionally, graphene functionalization also occurs, which is specific, without long-term heat treatment and catalyzing agents [15]. A possible explanation for the graphene functionalization is the formation of reactive radicals during the PMMA functionalization, which as a result leads, together with ethanolamine, to the graphene functionalization. Such modification is not acceptable for some sensors.

Despite the PMMA partial removal with the 2D/G increasing (>1.5 is considered acceptable [2]) and the threshold point shifting to zero (Fig. 3), the conductivity and mobility decrease. That is explained by the formation of alternating regions with ( $\sim$ 30–60 % of the surface) and without PMMA along the channel after THF:water cleaning, which differs in properties. The alternating can even reduce the CVC slope (Fig. 2,*d*, 3, *a*, *b*) in contrast to TCE cleaning, and to some known results. Although the AFM probe partially removes most of the PMMA from the graphene and shifts the threshold point closer to zero. Nevertheless, it does not lead to a significant increase in the CVC slope [16], in comparison with graphene purified by more efficient methods [1]. Thus even a small PMMA residual amount reduces the CVC slope.



Fig. 3. CVC measuring scheme (a), CVC (b) of initial graphene with PMMA and rinsed in solvents and the inset is the  $I_D$  changes relative to  $I_{D0}$  depending on  $V_G$ , where  $I_{D0}$  is  $I_D(V_G = 0 \text{ V})$ 

Hole mobility was estimated from CVC slope using a simple field-effect transistor equation:  $\mu_h = [(\Delta I_D / \Delta V_G)(L/W)]/(C_{ox}/V_D)$ , where *L*, *W* are the channel length and width;  $C_{ox} = 5 \,\mu\text{F/cm}^2$ is the gate electrolyte double-layer specific capacitance [17–19]. The estimated  $\mu_h$  for different structures are: 107 cm<sup>2</sup>/Vs for PMMA covered, 249 cm<sup>2</sup>/Vs for TCE, 202 cm<sup>2</sup>/Vs for THF:H<sub>2</sub>O. Significant  $\mu_h$  decrease for graphene cleaned by THF:H<sub>2</sub>O can be explained by the integrity destruction of the PMMA layer, remained after TCE, with the formation of an island character of the residual PMMA layer (Fig. 2, *a*, *d*). These graphene regions' alternation with and without polar groups of PMMA molecules can form charge density level or even conductivity type differences along the channel. It can significantly reduce gate control [20, 12]. Nevertheless, the  $I_D$ change relative to  $I_{D0}$  depending on  $V_G$  has a higher slope than for TCE (Fig. 3, *b*, inset), so the THF:H<sub>2</sub>O cleaned graphene resistive sensor has potentially higher sensitivity.

#### Conclusions

Trichloroethylene (TCE) cannot remove the near-surface PMMA layer. In comparison with TCE, for DAA:water there are: stress relaxation (2D peak shifts) with layer thickness increased due to swelling, but no 2D/G ratio change (~1.1). Also, graphene was partially removed due to the solvent high temperature (60  $^{\circ}$ C) while maintaining a high interaction energy of the remaining PMMA layer with graphene. For tetrahydrofuran (THF):water treatment, 2D/G increases to 1.6-1.9, and graphene regions without PMMA increase to ~50 nm and more. And according to AFM, redistributed PMMA still occupies about half of the graphene surface. 2D/G of AFM cleaned graphene was higher:  $\sim 2.7$  which is consistent with pure graphene Raman data. Although at AFM PMMA remains in several regions. Thus, the graphene cleaning control only by Raman is not enough, AFM is required. For ethanolamine (EA):THF, the 2D peak is shifted and 2D/G is 2.6 which points to extended graphene regions without PMMA. Although the AFM thickness is ~5 nm due to swelling. Thus, EA functionalization helps to remove PMMA, but graphene is functionalized too (D/G~0.7). Despite the PMMA partial removal after THF:water treatment with the 2D/G increasing and the threshold point shifting to zero, the conductivity and mobility decrease. The alternating of with and without PMMA regions forms different charge density levels or even conductivity types along the channel, which in turn significantly reduces channel control from the gate. Nevertheless, such resistive sensors might have better sensitivity.

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## THE AUTHORS

NEKRASOV Nikita P. 8141147@gmail.com ORCID: 0000-0003-1417-0177

LEVIN Denis D. skaldd@yandex.ru ORCID: 0000-0002-8414-6191

ROMASHKIN Al exey V. romaleval@gmail.com ORCID: 0000-0002-0101-6122

BOBRINETSKIY Ivan I. bobrinet@mail.ru ORCID: 0000-0003-2380-2594 BARSUKOV Leonty A. leonty.barsukov@gmail.com ORCID: 0000-0002-4802-0014

## **NEVOLIN Vladimir K.**

vkn@miee.ru ORCID: 0000-0003-4348-0377

# NIKITIN Konstantin G.

halkwww@mail.ru ORCID: 0000-0002-0457-4568

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